

Deep State Space Models for Nonlinear System Identification*

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Introduction

Deep SSM for Sequential Data

Model Parameter Learning

Numerical Experiments

Toy Problem: Linear Gaussian System

Narendra-Li Benchmark

Wiener-Hammerstein Process Noise Benchmark

- System identification: well-established field of automatic control
- Deep learning: successful for high dimensional and nonlinear problems emerging in diverse areas.
- State-Space Models (SSMs) given by:

$$\mathbf{h}_t = f_\theta(\mathbf{h}_{t-1}, \mathbf{u}_t, \mathbf{y}_t).$$

$$\hat{\mathbf{y}}_t = g_\theta(\mathbf{h}_t).$$

- Deep SSMs:
 - Extension of classic SSM with flexible Neural Networks (NNs); $f_\theta(\cdot)$ and $g_\theta(\cdot)$ as deep mappings.
 - More expressive than feed forward NN for temporal data.
 - Can capture system uncertainty.
- Goal of the paper:
 1. Show usefulness of deep SSMs for nonlinear system identification.
 2. Evaluate six deep SSMs on standard nonlinear system identification benchmarks.

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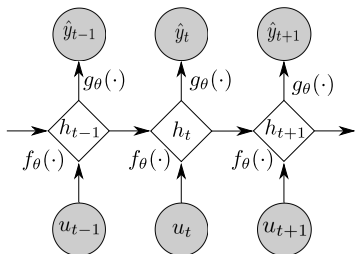
Toy Problem: Linear Gaussian System

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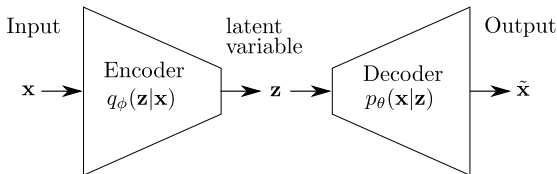
Recurrent Neural Network (RNN)

- Recursive propagation of hidden state.
- Dirac delta function as state transition distribution.



Variational Autoencoder (VAE)

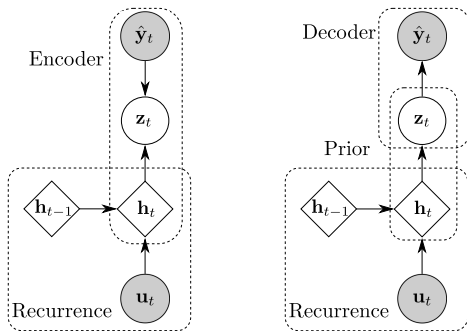
- Decoder: $p_\theta(\mathbf{x}|\mathbf{z}) = \mathcal{N}(\mathbf{x}|\boldsymbol{\mu}^{\text{dec}}, \boldsymbol{\sigma}^{\text{dec}})$,
 $[\boldsymbol{\mu}^{\text{dec}}, \boldsymbol{\sigma}^{\text{dec}}] = \text{NN}_\theta^{\text{dec}}(\mathbf{z})$.
- Prior: $p_\theta(\mathbf{z}) = \mathcal{N}(\mathbf{z}|\mathbf{0}, \mathbf{I})$.
- Encoder: $q_\phi(\mathbf{z}|\mathbf{x}) = \mathcal{N}(\mathbf{z}|\boldsymbol{\mu}^{\text{enc}}, \boldsymbol{\sigma}^{\text{enc}})$,
 $[\boldsymbol{\mu}^{\text{enc}}, \boldsymbol{\sigma}^{\text{enc}}] = \text{NN}_\phi^{\text{enc}}(\mathbf{x})$.



- Require a temporal extension of the VAE.

→ combine RNN and VAE

- Prior: update with RNN output,
 $p_{\theta}(\mathbf{z}_t | \mathbf{h}_t) = \mathcal{N}(\mathbf{z}_t | \boldsymbol{\mu}_t^{\text{prior}}, \boldsymbol{\sigma}_t^{\text{prior}}),$
 $[\boldsymbol{\mu}_t^{\text{prior}}, \boldsymbol{\sigma}_t^{\text{prior}}] = \text{NN}_{\theta}^{\text{prior}}(\mathbf{h}_t).$

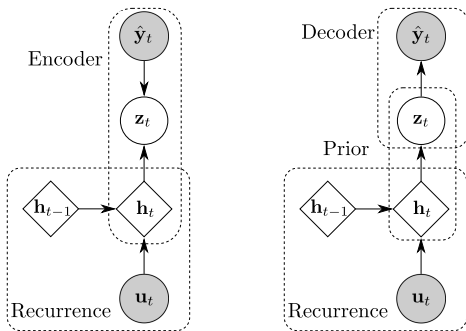


(a) Inference network (b) Generative network

Figure 1: Graphical model of VAE-RNN.

We study six different deep SSMs, specifically:

- **VAE-RNN**

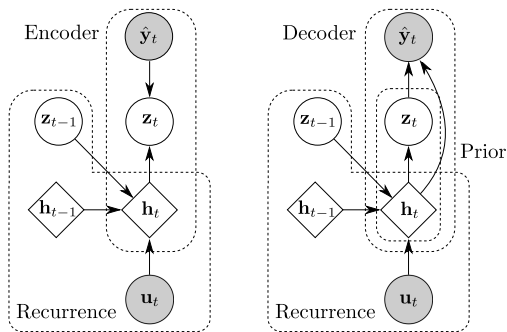


(a) Inference network **(b)** Generative network

Figure 2: Graphical model of VAE-RNN.

We study six different deep SSMs, specifically:

- **VAE-RNN**
- **Variational RNN (VRNN)**: recurrence additionally uses the previous latent variable \mathbf{z}_{t-1} .

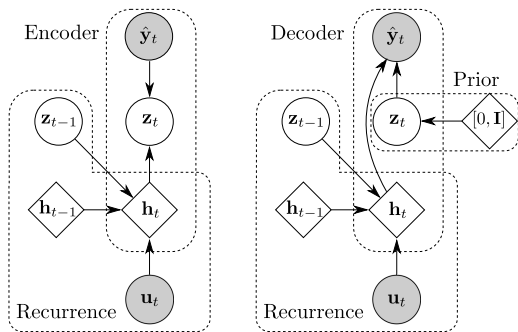


(a) Inference network (b) Generative network

Figure 3: Graphical model of VRNN.

We study six different deep SSMs, specifically:

- **VAE-RNN**
- **Variational RNN (VRNN)**: recurrence additionally uses the previous latent variable \mathbf{z}_{t-1} .
- **VRNN-I**: VRNN but with static prior.



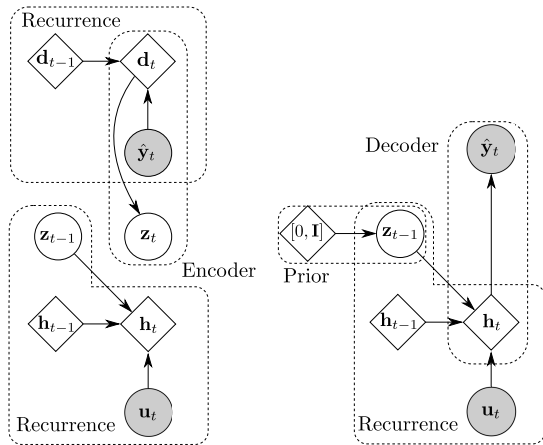
(a) Inference network (b) Generative network

Figure 4: Graphical model of VRNN-I.

We study six different deep SSMs, specifically:

- **VAE-RNN**
- **Variational RNN (VRNN)**: recurrence additionally uses the previous latent variable z_{t-1} .
- **VRNN-I**: VRNN but with static prior.
- **Stochastic RNN (STORN)**: Based on VRNN-I. Additional RNN in inference.

Additionally for VRNN and VRNN-I with Gaussian mixture output distribution.



(a) Inference network (b) Generative network

Figure 5: Graphical model of STORN.

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VAE parameter learning:

- Maximum likelihood $\mathcal{L}(\theta) = \sum_{i=1}^N \log p_{\theta}(x_i) = \sum_{i=1}^N \mathcal{L}_i(\theta)$ intractable.
- Approximate with Evidence Lower Bound (ELBO):
$$\mathcal{L}_i(\theta) \geq \mathbb{E}_{q_{\phi}(\mathbf{z}|\mathbf{x})} \left[\log \frac{p_{\theta}(\mathbf{x}, \mathbf{z})}{q_{\phi}(\mathbf{z}|\mathbf{x})} \right] = \tilde{\mathcal{L}}_i(\theta, \phi).$$
- Rewrite with KL-divergence: $\tilde{\mathcal{L}}_i(\theta, \phi) = \mathbb{E}_{q_{\phi}} [\log p_{\theta}(\mathbf{x}|\mathbf{z})] - \text{KL}(q_{\phi}(\mathbf{z}|\mathbf{x}) || p_{\theta}(\mathbf{z}))$.
- Maximize $\tilde{\mathcal{L}}(\theta, \phi) = \sum_{i=1}^N \tilde{\mathcal{L}}_i(\theta, \phi)$.

Deep SSM requires temporal extension of VAE parameter learning:

- ELBO as $\tilde{\mathcal{L}}(\theta, \phi) = \mathbb{E}_{q_{\phi}} \left[\log \frac{p_{\theta}(\mathbf{y}_{1:T}, \mathbf{z}_{1:T}, \mathbf{h}_{1:T} | \mathbf{u}_{1:T}, \mathbf{h}_0)}{q_{\phi}(\mathbf{z}_{1:T}, \mathbf{h}_{1:T} | \mathbf{y}_{1:T}, \mathbf{u}_{1:T}, \mathbf{h}_0)} \right]$.
- Factorize to obtain the following which is maximized
$$\begin{aligned} \tilde{\mathcal{L}}(\theta, \phi) &= \sum_{t=1}^T \mathbb{E}_{q_{\phi}} \left[\log \frac{p_{\theta}(\mathbf{y}_t | \mathbf{z}_t) p_{\theta}(\mathbf{z}_t | \mathbf{h}_t)}{q_{\phi}(\mathbf{z}_t | \mathbf{y}_t, \mathbf{h}_t)} \right] = \\ &= \sum_{t=1}^T \mathbb{E}_{q_{\phi}} [\log p_{\theta}(\mathbf{y}_t | \mathbf{z}_t)] - \text{KL}(q_{\phi}(\mathbf{z}_t | \mathbf{y}_t, \mathbf{h}_t) || p_{\theta}(\mathbf{z}_t | \mathbf{h}_t)), \end{aligned}$$

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Problem setup:

$$\mathbf{x}_{k+1} = \begin{bmatrix} 0.7 & 0.8 \\ 0 & 0.1 \end{bmatrix} \mathbf{x}_k + \begin{bmatrix} -1 \\ 0.1 \end{bmatrix} \mathbf{u}_k + \mathbf{v}_k,$$

$$\mathbf{y}_k = \begin{bmatrix} 1 & 0 \end{bmatrix} \mathbf{x}_k + \mathbf{w}_k,$$

$$\mathbf{v}_k \sim \mathcal{N}(0, 0.5 \cdot \mathbf{I}), \quad \mathbf{w}_k \sim \mathcal{N}(0, 1).$$

Toy Problem: Linear Gaussian System

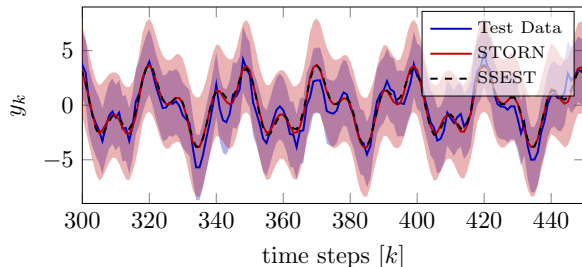


Table 1: Results for linear Gaussian toy problem.

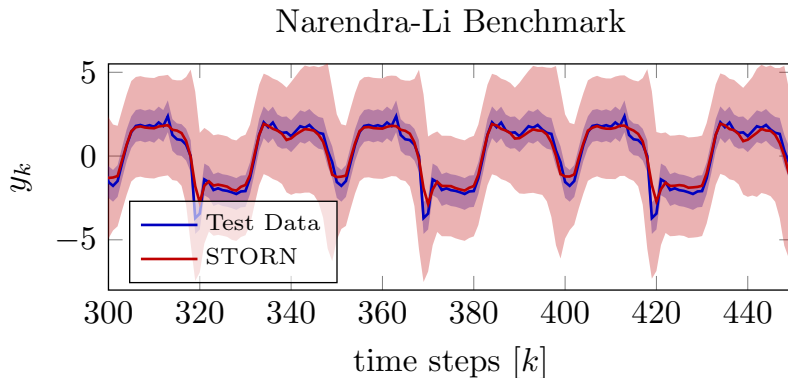
Model	RMSE	NLL
VAE-RNN	1.56	1.95
VRNN-Gauss-I	1.48	1.82
VRNN-Gauss	1.47	1.85
VRNN-GMM-I	1.45	1.80
VRNN-GMM	1.43	1.79
STORN	1.43	1.79
SSEST	1.41	1.78
True lin. model	1.34	-

Narendra-Li Benchmark: A highly nonlinear but non-physical, fictional system.

Table 2: Results for the Narendra-Li benchmark.

Model	RMSE	NLL	Samples
VAE-RNN	0.84	1.34	50 000
VRNN-Gauss-I	0.89	1.31	60 000
VRNN-Gauss	0.85	1.28	30 000
VRNN-GMM-I	0.87	1.29	20 000
VRNN-GMM	0.87	1.30	50 000
STORN	0.64	1.20	60 000
Multivariate adaptive regression splines	0.46	-	2 000
Adapt. hinging hyperplanes	0.31	-	2 000
Model-on-demand	0.46	-	50 000
Direct weight optimization	0.43	-	50 000
Basis function expansion	0.06	-	2 000

Results on time evaluation between test data and STORN 1-step ahead prediction.



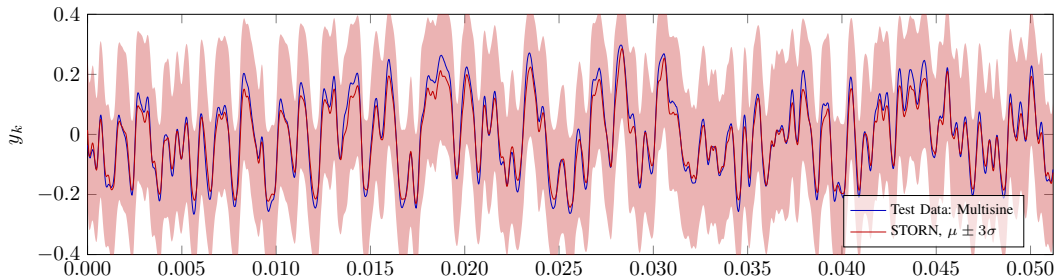
Benchmark: Measured input-output data from an electric circuit.
Nonlinearity between two linear dynamic systems.

Table 3: Results in RMSE for WH benchmark.

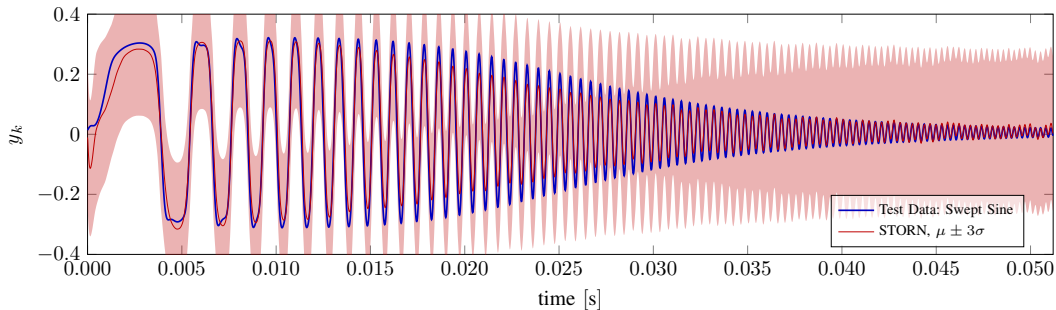
Model	swept sine	multisine
VAE-RNN	0.050	0.059
VRNN-Gauss-I	0.076	0.076
VRNN-Gauss	0.082	0.079
VRNN-GMM-I	0.066	0.067
VRNN-GMM	0.076	0.074
STORN	0.034	0.051
NOBF	≈ 0.2	< 0.3
NFIR	< 0.05	< 0.05
NARX	< 0.05	≈ 0.05
PNLSS	0.022	0.038
Best Linear Approx.	-	0.035
ML	-	0.016
SMC	0.014	0.015

Wiener-Hammerstein Process Noise Benchmark (2/2)

Wiener-Hammerstein Benchmark: Multisine Test Data



Wiener-Hammerstein Benchmark: Swept Sine Test Data



- Introduction to deep SSMs as an extension to SSMs
- Six deep SSMs are implemented and applied to nonlinear system identification benchmarks
- Results indicate that the class of deep SSMs is competitive to classic identification methods.
⇒ toolbox of nonlinear identification methods is extended by a new model class based on deep learning

Reproducible research:

https://github.com/dgedon/DeepSSM_SysID

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